Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 07977-103003

Application No. 10/811,920

JUL 1 9 2004

Corrected Information Disclosure Statement by Applicant (Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant Hongyong Zhang

Filing Date March 30, 2004

Group Art Unit

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Examiner Signature	Date Considered			
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1	n Disclosure Statement	Applicant Hongyong Zhang		
(Use several sheets if necessary) (37 CFR §1.98(b))		Filing Date March 30, 2004	Group Art Unit Unknown	

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Examiner Initial	Desig. ID	Document			
	BF				
	BG				
	ВН				
	BI				

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